

Search Notes

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Christopher RoDee

Applicant(s)/Patent under
Reexamination

FUJINO ET AL.

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SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
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	DATE	EXMR
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machine translations of JP 2001-235894 & JP 2003-091093 reviewed; searched for English language equivalents of other IDS docs	7/5/2006	CDR